



### DMT35M8LDG

#### ASYMMETRIC DUAL N-CHANNEL MOSFET PowerDI3333-8

# **Product Summary**

Device	BVDSS	Rds(ON) Max	I <sub>D</sub> Max T <sub>A</sub> = +25°C
Q1	30V	4.7mΩ @ V <sub>GS</sub> = 10V	17.0A
		5.7mΩ @ V <sub>GS</sub> = 4.5V	15.5A
Q2	201/	5.8mΩ @ V <sub>GS</sub> = 10V	15.3A
	30V	7.3mΩ @ V <sub>GS</sub> = 4.5V	13.7A

### **Description**

This MOSFET has been designed to minimize the on-state resistance (RDS(ON)) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## **Applications**

• Power management functions

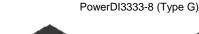
#### **Features**

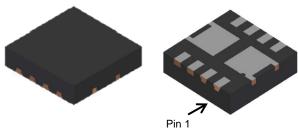
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/quality/product-definitions/

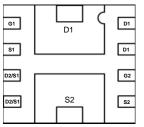
#### **Mechanical Data**

- Package: PowerDI®3333-8
- Package Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Lead Frame. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.029 grams (Approximate)

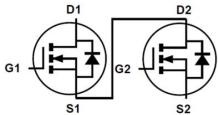




Top View Bottom View



**Bottom View** 



Q1 N-Channel MOSFET Q2 N-Channel MOSFET

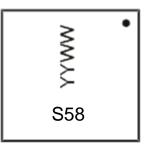
### **Ordering Information** (Note 4)

Part Number	Package	Packing		
Fait Number	Package	Qty.	Carrier	
DMT35M8LDG-7	PowerDI3333-8 (Type G)	2000	Tape & Reel	
DMT35M8LDG-13	PowerDI3333-8 (Type G)	3000	Tape & Reel	

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.



# **Marking Information**



S58 = Product Type Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 22 = 2022) WW = Week Code (01 to 53)

# Maximum Ratings N-CHANNEL – Q1 & Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1 N-CHANNEL	Q2 N-CHANNEL	Unit	
Drain-Source Voltage		VDSS	30	30	V
Gate-Source Voltage		Vgss	±12	±12	V
Continuous Drain Current (Note 5) VGs = 10V	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	17.0 13.6	15.3 12.3	А
Maximum Continuous Body Diode Forward Current (Note	Is	2.7	2.6	Α	
Pulsed Drain Current	IDM	90	90	Α	
Pulsed Body Diode Forward Current (10µs Pulse, Duty C	Isм	90	90	Α	
Avalanche Current (Note 7) L = 0.1mH	I <sub>AS</sub>	24	18	Α	
Avalanche Energy (Note 7) L = 0.1mH	Eas	29	18	mJ	

### Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 8) $T_A = +25^{\circ}C$		PD	0.98	W
Thermal Resistance, Junction to Ambient (Note 8)	$R_{\theta JA}$	129	°C/W	
Total Power Dissipation (Note 5) $T_C = +25^{\circ}C$		PD	2	W
Thermal Resistance, Junction to Ambient (Note 5)	RθJA	61	°C/W	
Thermal Resistance, Junction to Case (Note 6)	R <sub>θ</sub> JC	12.1	°C/W	
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1-inch square copper plate.
  6. Thermal resistance from junction to soldering point (on the exposed drain pad).
  7. Ias and Eas ratings are based on low frequency and duty cycles to keep TJ = +25°C.
  8. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.



# Electrical Characteristics N-CHANNEL - Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	IDSS	_	_	1.0	μΑ	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	Igss	_	_	±100	nA	$V_{GS} = \pm 12V$ , $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 9)							
Gate Threshold Voltage	VGS(TH)	1	_	1.9	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D	_	1.8	4.7	mΩ	$V_{GS} = 10V, I_D = 20A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	2.5	5.7	11122	$V_{GS} = 4.5V, I_D = 20A$	
Diode Forward Voltage	VsD	_	0.8	1	V	V <sub>G</sub> S = 0V, I <sub>S</sub> = 1A	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	Ciss	_	1510	_	pF	.,	
Output Capacitance	Coss	_	1006	_	pF	$V_{DS} = 15V, V_{GS} = 0V$ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	_	49	_	pF		
Gate Resistance	Rg	_	0.6	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	14.5	_	nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	22.7	_	nC	\/ 45\/ I- 20A	
Gate-Source Charge	Qgs	_	3.2	_	nC	V <sub>DS</sub> = 15V, I <sub>D</sub> = 20A	
Gate-Drain Charge	$Q_{gd}$	_	7.9	_	nC		
Turn-On Delay Time	td(on)	_	8.4	_	ns		
Turn-On Rise Time	t <sub>R</sub>	_	12.2	_	ns	$V_{DS} = 15V$	
Turn-Off Delay Time	tD(OFF)	_	18.6	_	ns	$R_g = 3\Omega, I_D = 18A$	
Turn-Off Fall Time	t <sub>F</sub>	_	3.9	_	ns	]	
Reverse Recovery Time	trr	_	24.4	_	ns	I 200 dl/dk 400 0 //	
Reverse Recovery Charge	Q <sub>RR</sub>	_	25.3	_	nC	IF = 20A, dI/dt = 400A/μs	

Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.



# Electrical Characteristics N-CHANNEL - Q2 (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V, I_{D} = 250\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	IDSS	_	_	1.0	μA	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	Igss	_	_	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 9)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1	_	1.9	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D	_	3.7	5.8	mΩ	$V_{GS} = 10V, I_D = 18A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	4.9	7.3	11177	$V_{GS} = 4.5V, I_D = 18A$	
Diode Forward Voltage	VsD	_	0.8	1.2	V	Vgs = 0V, Is = 18A	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	Ciss	_	1032	_	pF		
Output Capacitance	Coss	_	711	_	pF	$V_{DS} = 15V, V_{GS} = 0V$ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	_	38	_	pF	1 = 1.0ivii iz	
Gate Resistance	Rg	_	1.3	_	Ω	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 0V, f = 1MHz	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	_	7.5	_	nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg		16.3		nC	\/ 45\/  _ 40A	
Gate-Source Charge	Qgs	1	2.1		nC	$V_{DS} = 15V, I_{D} = 18A$	
Gate-Drain Charge	$Q_{gd}$	_	1.7	_	nC		
Turn-On Delay Time	td(ON)	_	9.6	_	ns		
Turn-On Rise Time	t <sub>R</sub>		13.4	_	ns	V <sub>DS</sub> = 15V	
Turn-Off Delay Time	tD(OFF)	_	22.4	_	ns	$R_g = 6\Omega$ , $I_D = 18A$	
Turn-Off Fall Time	t <sub>F</sub>	_	4.3	_	ns		
Reverse Recovery Time	trr	_	18.6	_	ns	I_ 20A d1/d4 400A/c-	
Reverse Recovery Charge	Qrr		16.6		nC	IF = 20A, dl/dt = 400A/µs	

Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.



### N-CHANNEL - Q1

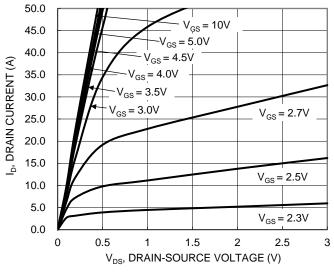


Figure 1. Typical Output Characteristic

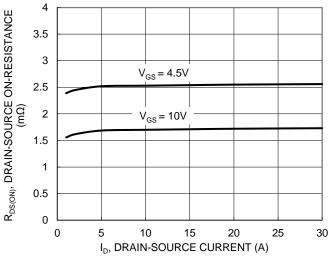


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

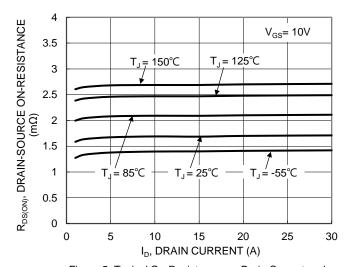


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

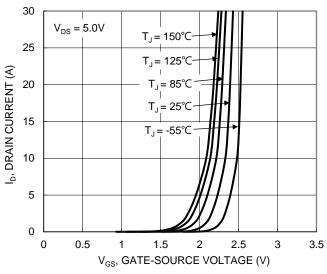


Figure 2. Typical Transfer Characteristic

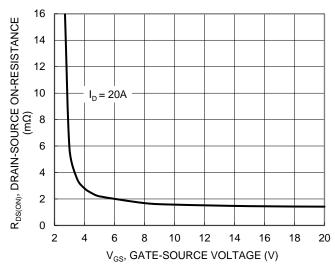


Figure 4. Typical Transfer Characteristic

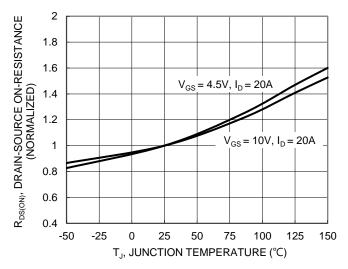


Figure 6. On-Resistance Variation with Temperature



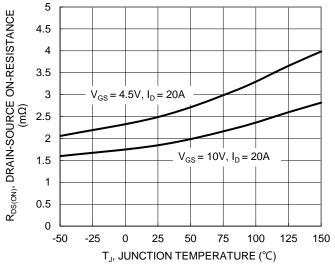


Figure 7. On-Resistance Variation with Temperature

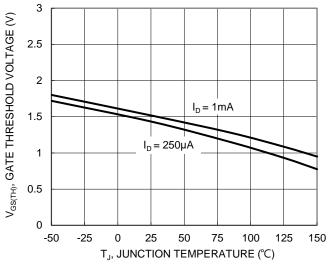


Figure 8. Gate Threshold Variation vs Junction Temperature

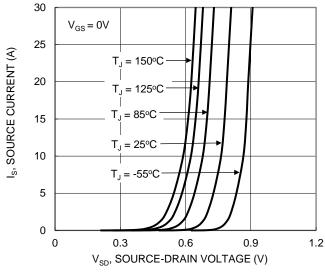


Figure 9. Diode Forward Voltage vs. Current

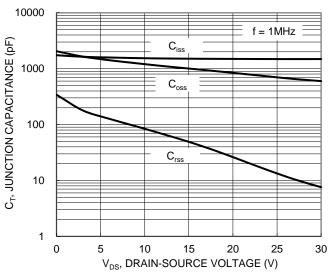


Figure 10. Typical Junction Capacitance

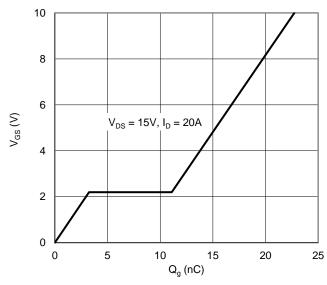


Figure 11. Gate Charge

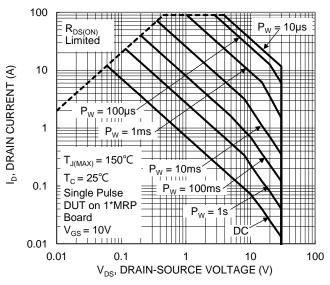
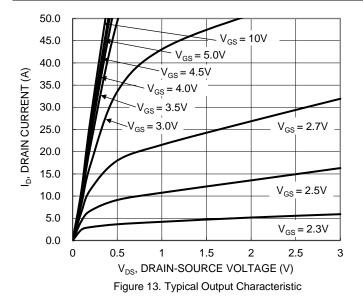
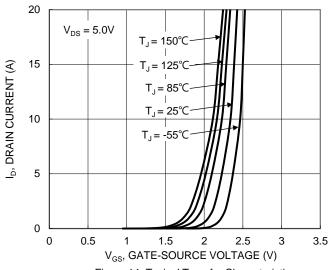


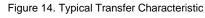
Figure 12. SOA, Safe Operation Area

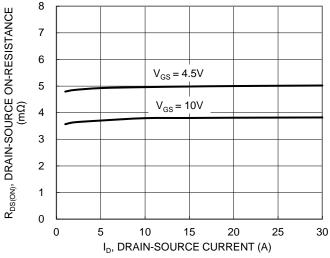


### N-CHANNEL - Q2









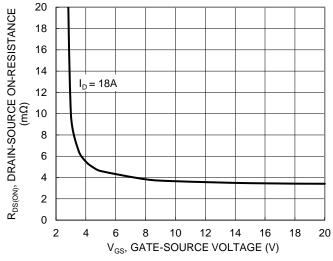
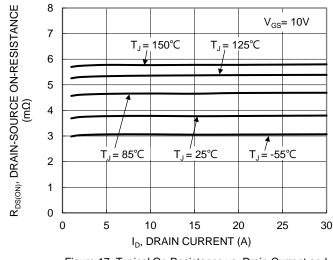


Figure 15. Typical On-Resistance vs. Drain Current and Gate Voltage





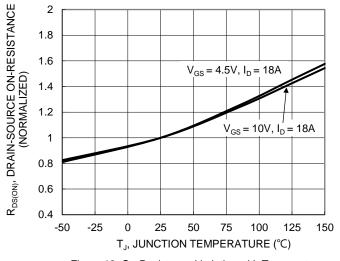


Figure 17. Typical On-Resistance vs. Drain Current and Temperature

Figure 18. On-Resistance Variation with Temperature



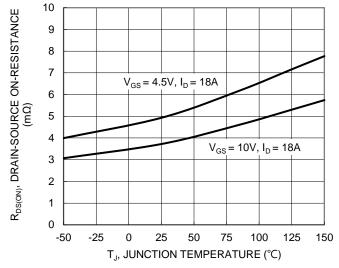


Figure 19. On-Resistance Variation with Temperature

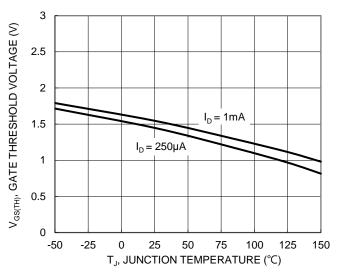


Figure 20. Gate Threshold Variation vs. Junction Temperature

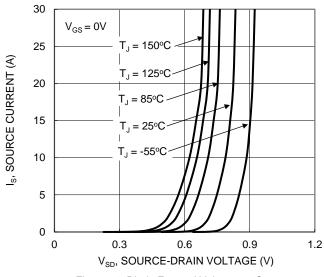


Figure 21. Diode Forward Voltage vs. Current

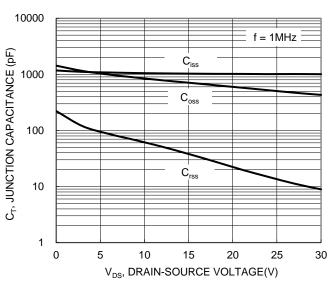


Figure 22. Typical Junction Capacitance

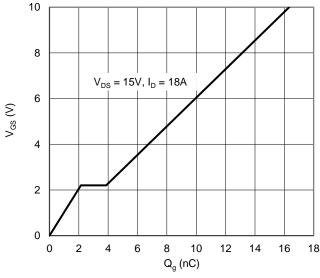


Figure 23. Gate Charge

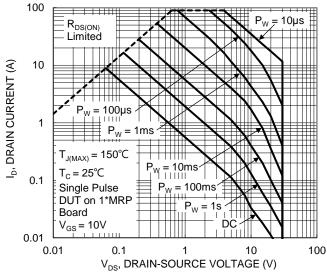


Figure 24. SOA, Safe Operation Area



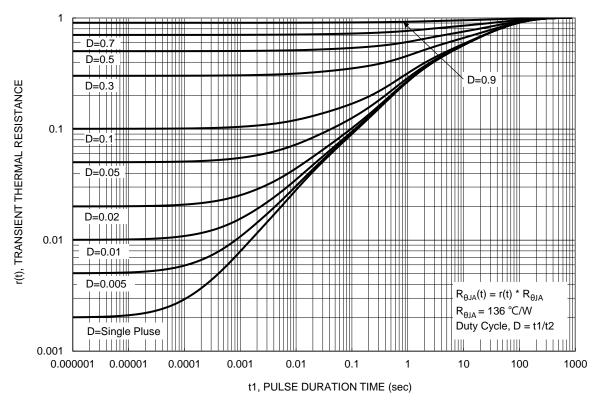


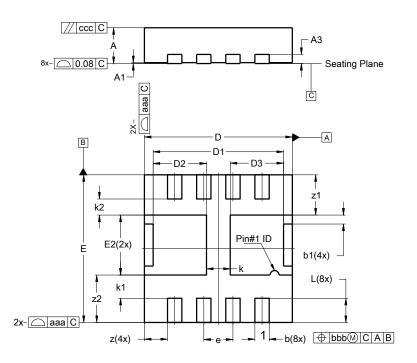
Figure 25. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### PowerDI3333-8 (Type G)

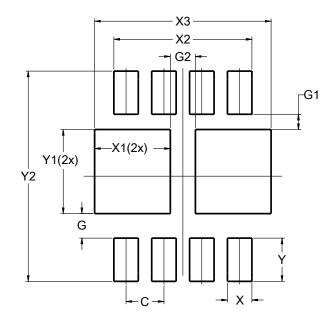


PowerDI3333-8 (Type G)						
Dim	Min	Max	Тур			
Α	0.75	0.85	0.80			
A1	0.00	0.05	0.02			
A3		-	0.203			
b	0.27	0.37	0.32			
b1	0.15	0.25	0.20			
D	3.25	3.35	3.30			
D1	2.81	3.01	2.91			
D2	1.09	1.29	1.19			
D3	1.09	1.29	1.19			
Е	3.25	3.25 3.35 3.30				
E2	1.24	1.44	1.34			
е	(	0.65BSC				
L	0.49	0.59	0.54			
k			0.53			
k1			0.52			
k2			0.36			
Z	0.515					
z1			0.90			
z2	1.06					
aaa	0.25					
bbb	0.10					
CCC	0.10					
All Dimensions in mm						

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI3333-8 (Type G)



Dimensions	Value		
Dillielisions	(in mm)		
С	0.650		
G	0.420		
G1	0.260		
G2	0.430		
Х	0.420		
X1	1.300		
X2	2.370		
Х3	3.030		
Υ	0.740		
Y1	1.440		
Y2	3.600		



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